

Notic of Referenc s Cited	Application/Control No. 09/857,308		Applicant(s)/Patent Under Reexamination ITOH ET AL.	
	Examiner Christopher H Yaen		Art Unit 1642	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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	N	WO 99/45954			Sette et al	
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Evans et al Q.J.Med 1999;92:299-307
	V	Gura (Science, v278, 1997, pp.1041-1042)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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